onsemi

MOSFET - Power, N-Channel, PowerTrench[®] Power Clip, Symmetric Dual ^{30 V} NTTFD2D8N03P1E

Features

- Small Footprint (3.3mm x 3.3mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- $\bullet \ Low \ Q_G$ and Capacitance to Minimize Driver Losses
- These Devices are Pb-Free and are RoHS Compliant

Typical Applications

- DC-DC Converters
- System Voltage Rails

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Para	neter		Symbol	Q1	Q2	Unit
Drain-to-Source Volt	age		V _{DSS}	30	30	V
Gate-to-Source Volt	age		V _{GS}	+16 -12	+16 -12	V
Continuous Drain Current $R_{\theta,IC}$		$T_C = 25^{\circ}C$	Ι _D	80	80	А
(Note 3)	Steady	$T_C = 85^{\circ}C$		58	58	
Power Dissipation $R_{\theta JC}$ (Note 3)	State	$T_A = 25^{\circ}C$	P _D	26	26	W
Continuous Drain Current $R_{\theta,IA}$		$T_A = 25^{\circ}C$	Ι _D	21.1	21.1	А
(Notes 1, 3)	Steady	$T_A = 85^{\circ}C$		15.2	15.2	
Power Dissipation $R_{\theta JA}$ (Notes 1, 3)	State	$T_A = 25^{\circ}C$	PD	1.79	1.79	W
Continuous Drain		$T_A = 25^{\circ}C$	I _D	16.1	16.1	А
Current R _{θJA} (Notes 2, 3)	Steady	$T_A = 85^{\circ}C$		11.6	11.6	
Power Dissipation $R_{\theta JA}$ (Notes 2, 3)	State	$T_A = 25^{\circ}C$	P _D	1.04	1.04	W
Pulsed Drain Current	T _A = 25°0	C, t _p = 10 μs	I _{DM}	327	356	А
	E _{AS}	55.4	58.8	mJ		
Operating Junction and	T _J , T _{stg}	-55 to + 150		°C		
Lead Temperature for Purposes (1/8" from			ΤL	260		°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

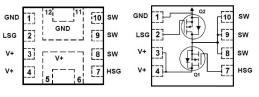
- 1. Surface-mounted on FR4 board using a 1 in² pad size, 2 oz. Cu pad.
- 2. Surface-mounted on FR4 board using minimum pad size, 2 oz. Cu pad.
- 3. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted. Actual continuous current will be limited by thermal & electro–mechanical application board design. R_{0,JC} is determined by the user's board design.
- 4. Q1 100% UIS tested at L = 0.1 mH, IAS = 21.1 A.

Q2 100% UIS tested at L = 0.1 mH, IAS = 21.1 A.

5. This device is Class 1B ESD HBM Rating.

FET	V _{(BR)DSS} R _{DS(ON)} MAX		I _D MAX
Q1	30 V	$2.5~\mathrm{m}\Omega$ @ 10 V	80 A
QI	30 V	$3.0~\text{m}\Omega$ @ $4.5~\text{V}$	60 A
Q2	30 V 2.5 mΩ @ 10 V		80 A
Q2	30 V	$3.0~\text{m}\Omega$ @ $4.5~\text{V}$	60 A

ELECTRICAL CONNECTION





=	Y	ea		

ww

ΖZ

- = Work Week
 - = Assembly Lot Code

ORDERING INFORMATION

Device	Package	Shipping [†]
NTTFD2D8N03P1E	WQFN12 (Pb-Free)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Q1 Max	Q2 Max	Unit
Junction-to-Case - Steady State (Notes 1, 3)	$R_{ heta JC}$	4.8	4.8	°C/W
Junction-to-Ambient - Steady State (Notes 1, 3)	$R_{ hetaJA}$	70	70	
Junction-to-Ambient - Steady State (Notes 2, 3)	$R_{\theta JA}$	120	120	

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition	FET	Min	Тур	Max	Unit
OFF CHARACTERISTICS							

OIT ONANAOTENISTICS								
Drain-to-Source Breakdown	V _{(BR)DSS}	V_{GS} = 0 V, I _D =	1 mA	Q1	30			Ň
Voltage		V_{GS} = 0 V, I _D =	1 mA	Q2	30		V	
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /	I _D = 1 mA, ref to	≥25°C	Q1		17.9		mV/°C
	١J	$I_D = 1 \text{ mA}, \text{ ref to } 25^{\circ}\text{C}$		Q2		17.2		mv/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$	Q1			1.0	
		V _{DS} = 24 V		Q2			1.0	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{GS} = +1$	6 V / -12 V	Q1			±100	-
		V _{DS} = 0 V, V _{GS} = +1	6 V / –12 V	Q2	=		±100	nA

ON CHARACTERISTICS (Note 6)

Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 400 \ \mu A$	Q1	1.2		2.2	V
		$V_{GS} = V_{DS}$, $I_D = 400 \ \mu A$	Q2	1.2		2.2	v
Negative Threshold Temperature Coefficient	$V_{GS(TH)}/T_J$	$I_D = 400 \ \mu A$, ref to $25^{\circ}C$	Q1		-4.3		
		$I_D = 400 \ \mu A$, ref to $25^{\circ}C$	Q2		-4.5		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V_{GS} = 10 V, I _D = 18 A	Q1		2.0	2.5	
		V_{GS} = 4.5 V, I _D = 16 A			2.6	3.0	m ()
		V_{GS} = 10 V, I _D = 18 A	Q2		1.8	2.5	mΩ
		V_{GS} = 4.5 V, I _D = 16 A			2.4	3.0	
Forward Transconductance	9fs	$V_{DS} = 5 V, I_{D} = 18 A$	Q1		129		0
		$V_{DS} = 5 V, I_{D} = 18 A$	Q2		141		S
Gate-Resistance	R _G	$T_A = 25^{\circ}C$	Q1		0.68		0
			Q2		0.75		Ω

CHARGES, CAPACITANCES & GATE RESISTANCE

Input Capacitance	C _{ISS}		Q1	1500	рF
			Q2	1521	рі
Output Capacitance	C _{OSS}		Q1	483	рF
		V _{GS} = 0 V, V _{DS} = 15 V, f = 1 MHz	Q2	498	pΓ
Reverse Transfer Capacitance	C _{RSS}		Q1	29	ρF
			Q2	22	рг

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 6. Pulse Test: pulse width $\leq 300 \ \mu$ s, duty cycle $\leq 2\%$.

7. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise specified)

Parameter	Symbol	Test Condition	FET	Min	Тур	Max	Unit		
CHARGES, CAPACITANCES & GATE RESISTANCE									
Total Gate Charge	Q _{G(TOT)}		Q1		9.5		nC		
			Q2		9.3		no		
Gate-to-Drain Charge	Q _{GD}	$ \begin{array}{c} \mathbf{Q}_{GD} \\ \mathbf{Q}_{1}: \mathbf{V}_{GS} = 4.5 \text{V}, \mathbf{V}_{DS} = 15 \text{V}; \mathbf{I}_{D} = 18 \text{A} \\ \mathbf{Q}_{2}: \mathbf{V}_{GS} = 4.5 \text{V}, \mathbf{V}_{DS} = 15 \text{V}; \mathbf{I}_{D} = 18 \text{A} \end{array} $	Q1		2.0		nC		
			Q2		1.6		no		
Gate-to-Source Charge	Q _{GS}		Q1		3.7		nC		
			Q2		3.7		no		
Total Gate Charge	Q _{G(TOT)}	Q1: V_{GS} = 10 V, V_{DS} = 15 V; I_{D} = 18 A	Q1		20.8		nC		
		Q2: V_{GS} = 10 V, V_{DS} = 15 V; I_{D} = 18 A	Q2		20.5		nc		

SWITCHING CHARACTERISTICS, VGS = 4.5 V (Note 7)

Turn-On Delay Time	t _{d(ON)}		Q1	13	20
			Q2	13.3	ns
Rise Time	tr	V_{GS} = 4.5 V Q1: I _D = 18 A, V _{DD} = 15 V, R _G = 6 Ω Q2: I _D = 18 A, V _{DD} = 15 V, R _G = 6 Ω	Q1	5.5	20
			Q2	5.8	ns
Turn-Off Delay Time	t _{d(OFF)}	Q2: $I_D = 18 \text{ A}, V_{DD} = 15 \text{ V}, H_G = 6 \Omega$	Q1	18.9	20
			Q2	19	ns
Fall Time	t _f		Q1	5.5	20
		F	Q2	5.5	ns

SWITCHING CHARACTERISTICS, VGS = 10 V (Note 7)

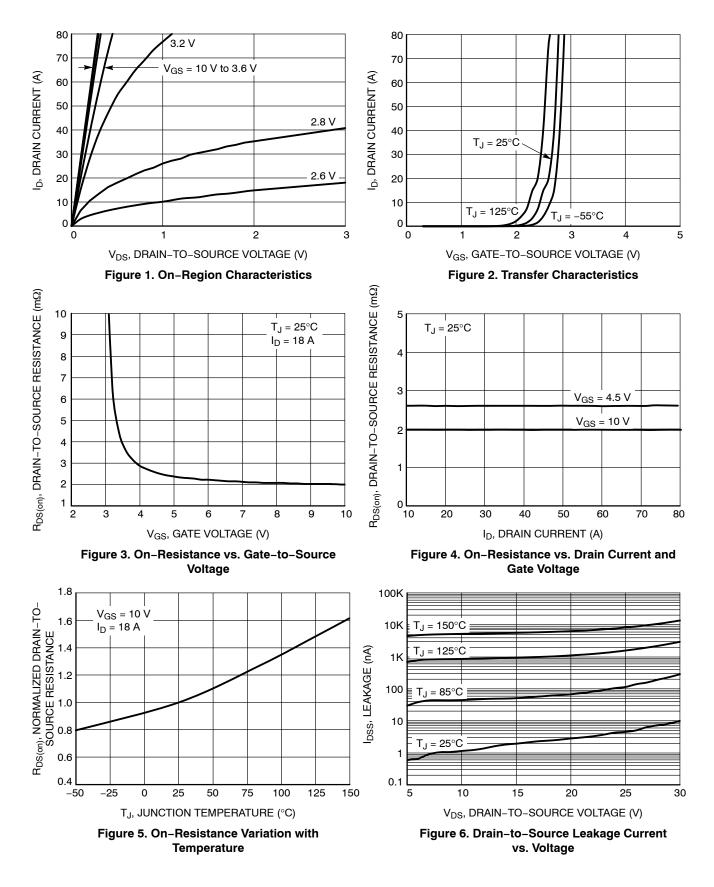
Turn-On Delay Time	t _{d(ON)}		Q1	8.4	20	
			Q2	8.7	ns	
Rise Time	t _r		Q1	2	20	
		$V_{GS} = 10 \text{ V}$ Q1: I _D = 18 A, V _{DD} = 15 V, R _G = 6 Ω	Q2	2	ns	
Turn-Off Delay Time	t _{d(OFF)}	Q1. ID = 18 A, V_{DD} = 15 V, R_{G} = 0 Ω Q2: I _D = 18 A, V_{DD} = 15 V, R_{G} = 6 Ω	Q1	26.3		
		Q2	26.3	ns		
Fall Time	t _f		Q1	3.8	20	
		F	Q2	3.6	ns	

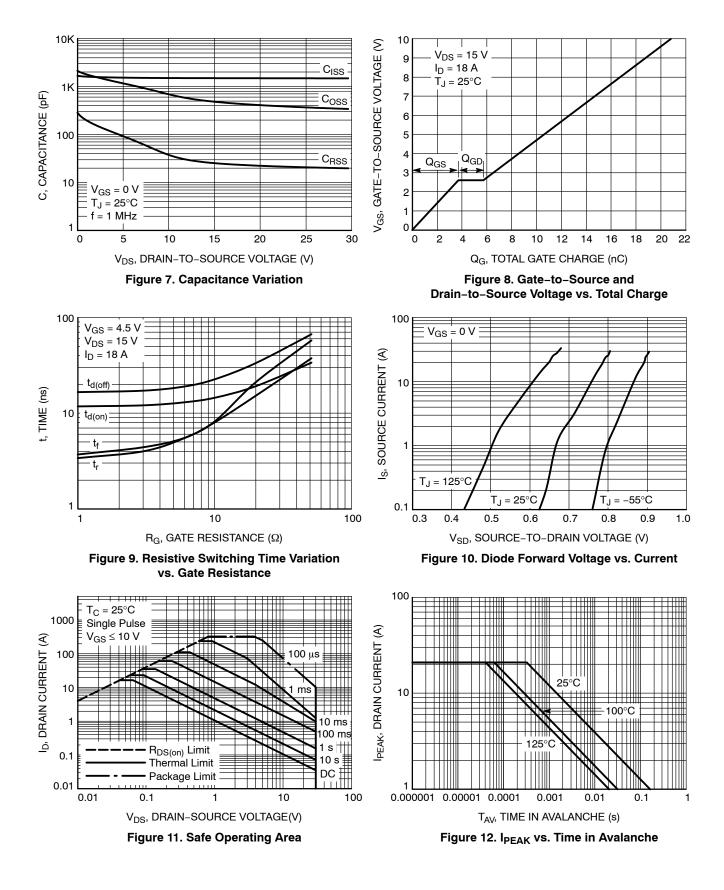
DRAIN-SOURCE DIODE CHARACTERISTICS

Forward Diode Voltage Vs	V _{SD}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$	Q1	0.8	1.2	
		I _S = 18 A	T _J = 125°C		0.67		V
		V _{GS} = 0 V, I _S = 18 A	$T_J = 25^{\circ}C$	Q2	0.8	1.2	v
		I _S = 18 A	T _J = 125°C		0.66		
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, V _{DD} = 15 V Q1: I _S = 18 A, dI _S /dt = 100 A/µs		Q1	30		ns
				Q2	29		
Reverse Recovery Charge	Q _{RR}	Q2: $I_S = 18 \text{ A}, dI_S/dt$	= 100 A/μs = 100 A/μs	Q1	13		nC
				Q2	12.5		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

6. Pulse Test: pulse width $\leq 300 \ \mu$ s, duty cycle $\leq 2\%$. 7. Switching characteristics are independent of operating junction temperatures.





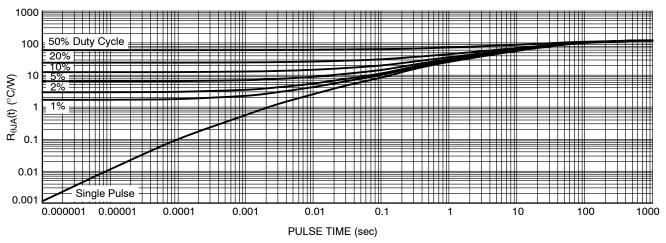
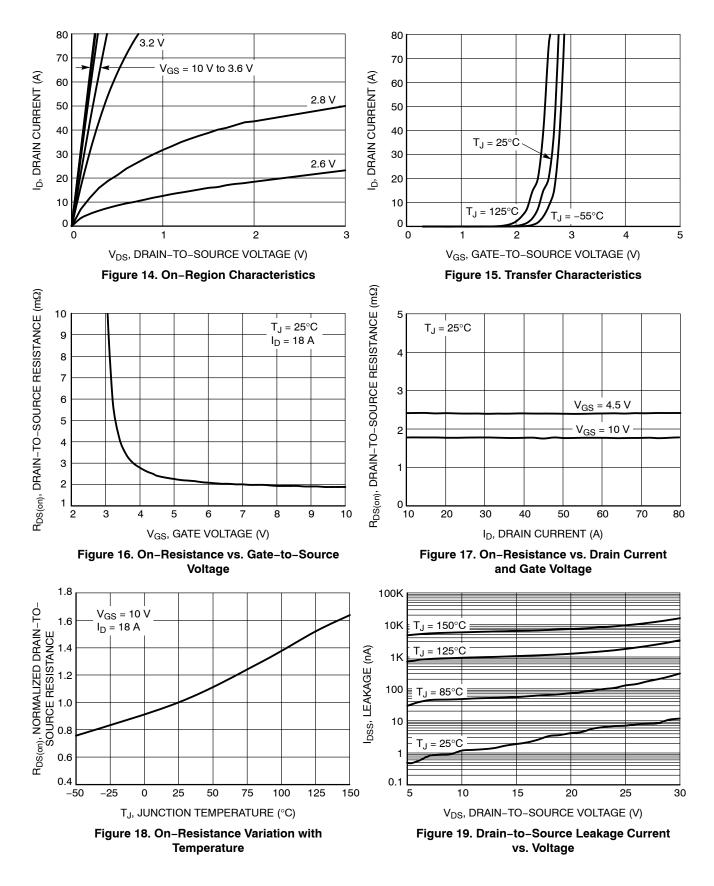
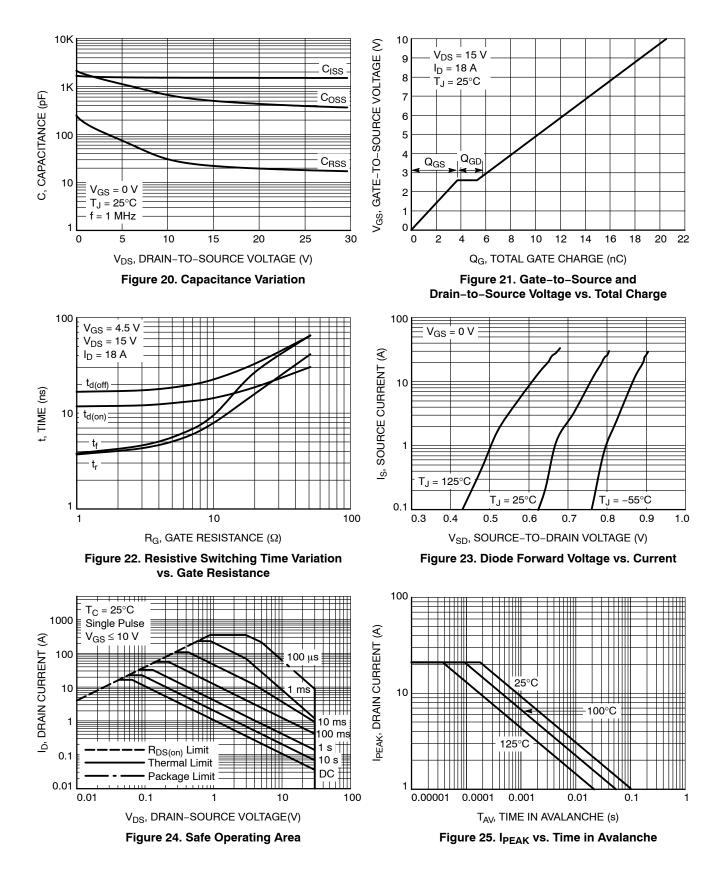


Figure 13. Thermal Characteristics





TYPICAL CHARACTERISTICS – Q2

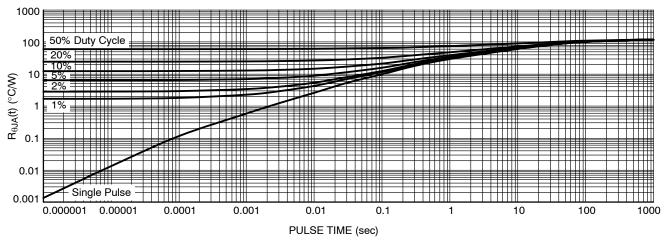


Figure 26. Thermal Characteristics

POWERTRENCH is a registered trademark of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries.

DUSEM

NOM

0.75

0.20 REF

0.32

3.30

1.44

0.20

3.30

1.19

0.30

0.65 BSC

0.325 BSC

1.24 BSC

0.33 REF

0.43 REF

0.54

0.29

0.25

MAX

0.80

0.05

0.37

3.40

1.54

0.30

3.40

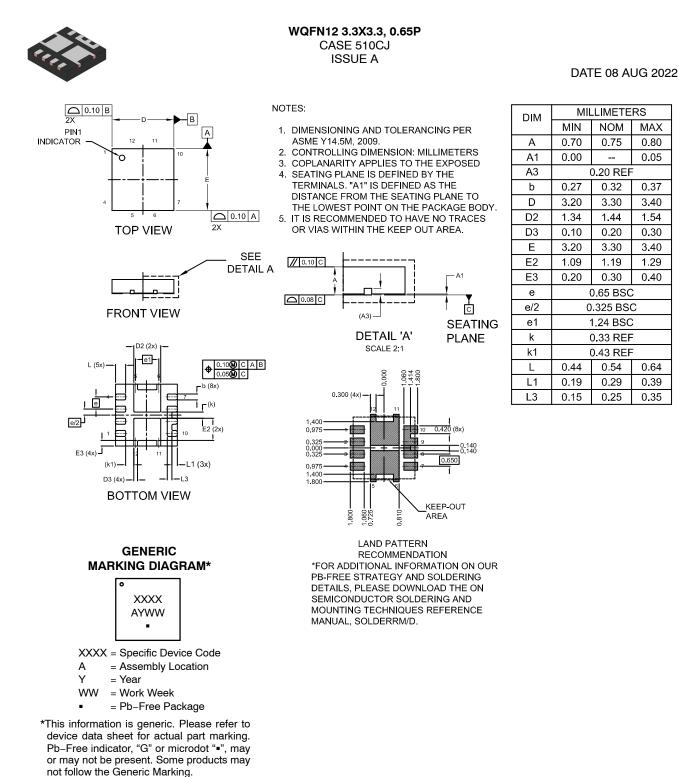
1.29

0.40

0.64

0.39

0.35



DESCRIPTION:	WQFN12 3.3X3.3, 0.65P	•	PAGE 1 OF 1

onsemi and ONSEMI are trademarks of Semiconductor Components Industries, LLC dba onsemi or its subsidiaries in the United States and/or other countries. onsemi reserves the right to make changes without further notice to any products herein. onsemi makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. onsemi does not convey any license under its patent rights nor the rights of others.

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does **onsemi** assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using **onsemi** products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by **onsemi**. "Typical" parameters which may be provided in **onsemi** data sheets and/or specifications can and do vary in different applications and calcular performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. **onsemi** does not convey any license under any of its intellectual property rights nor the rights of others. **onsemi** products are not designed, intended, or authorized for use as a critical component in life support systems. or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use **onsemi** products for any such unintended or unauthorized application, Buyer shall indemnify and hold **onsemi** and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that **onsemi** was negligent regarding the design or manufacture of the part. **onsemi** is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

TECHNICAL SUPPORT

onsemi Website: www.onsemi.com

Email Requests to: orderlit@onsemi.com

North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support: Phone: 00421 33 790 2910 For additional information, please contact your local Sales Representative